

Beam-Induced Fluorescence Monitors

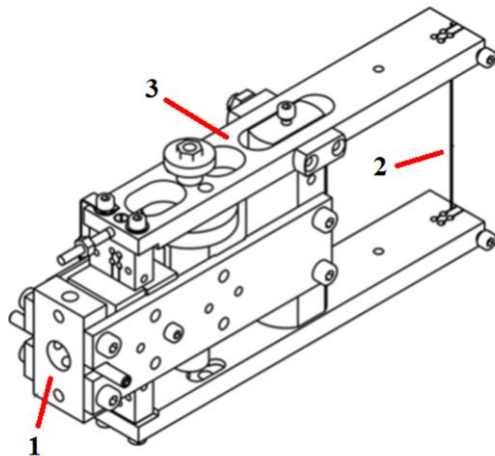
Semesterproject

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Introduction & Definitions

- ♦ Beam diagnostics (beam shape, position, intensity, emittance, ...) is indispensable
- ♦ There are two kinds of measurements to distinguish

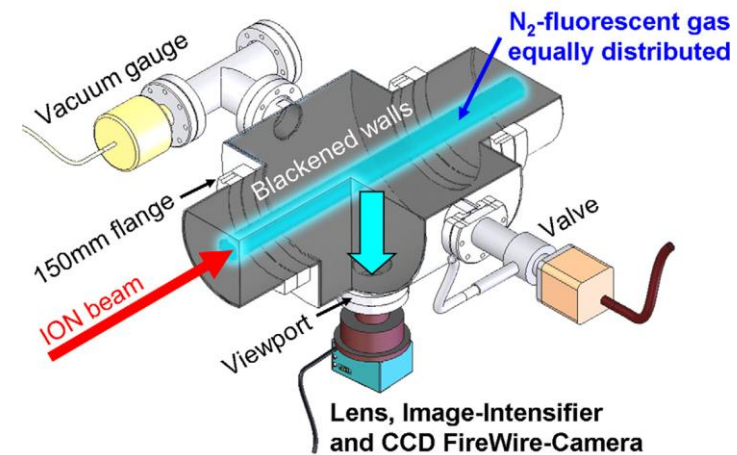
Intrusive measurements



[1]

- Direct measurement
- Good resolution, strong signal, but:
 - Difficult/impossible for high brightness beams
 - May introduce secondary particles disturbing the beam and other devices

Non-Intrusive measurements

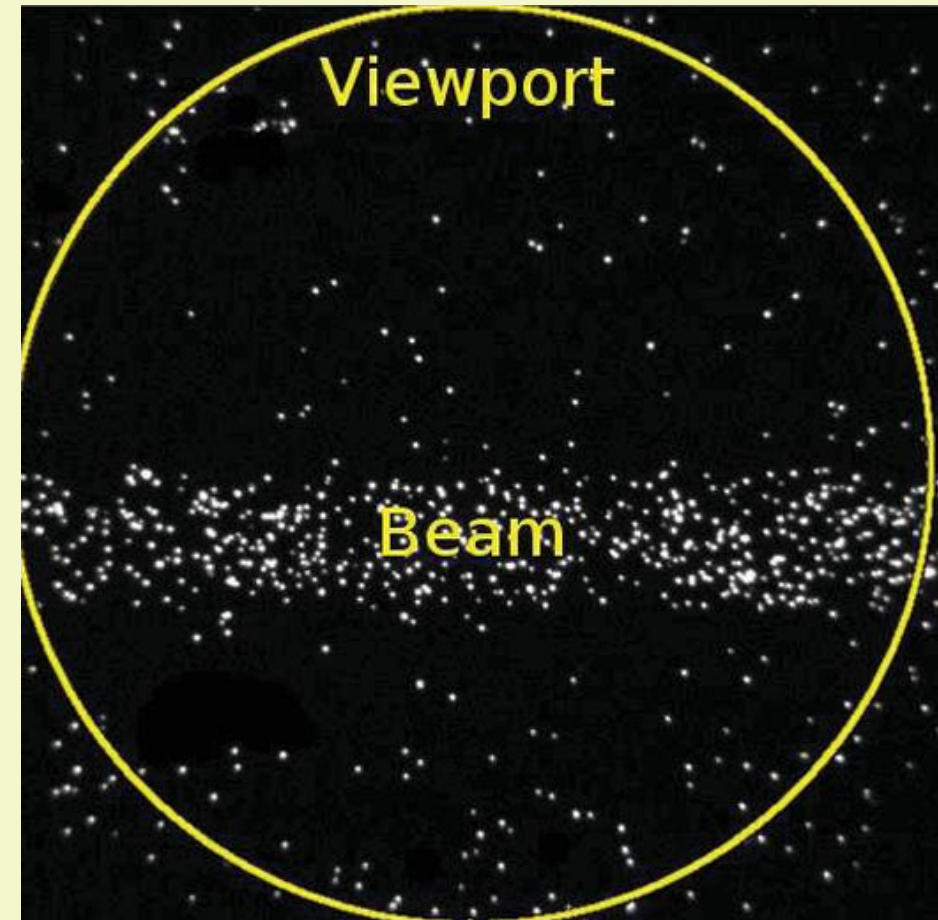


[2]

- LPM
- RGM
- BIF
- MWL
- ...
- RGI

Beam Induced Fluorescence Monitoring

- Particles (in our case protons) travel through vacuum tube
- Vacuum is never perfect. So residual gas is present
- Protons excite gas atoms through interaction
- During de-excitation, gas atoms may release photons
- Reveals the beam position:



[3]

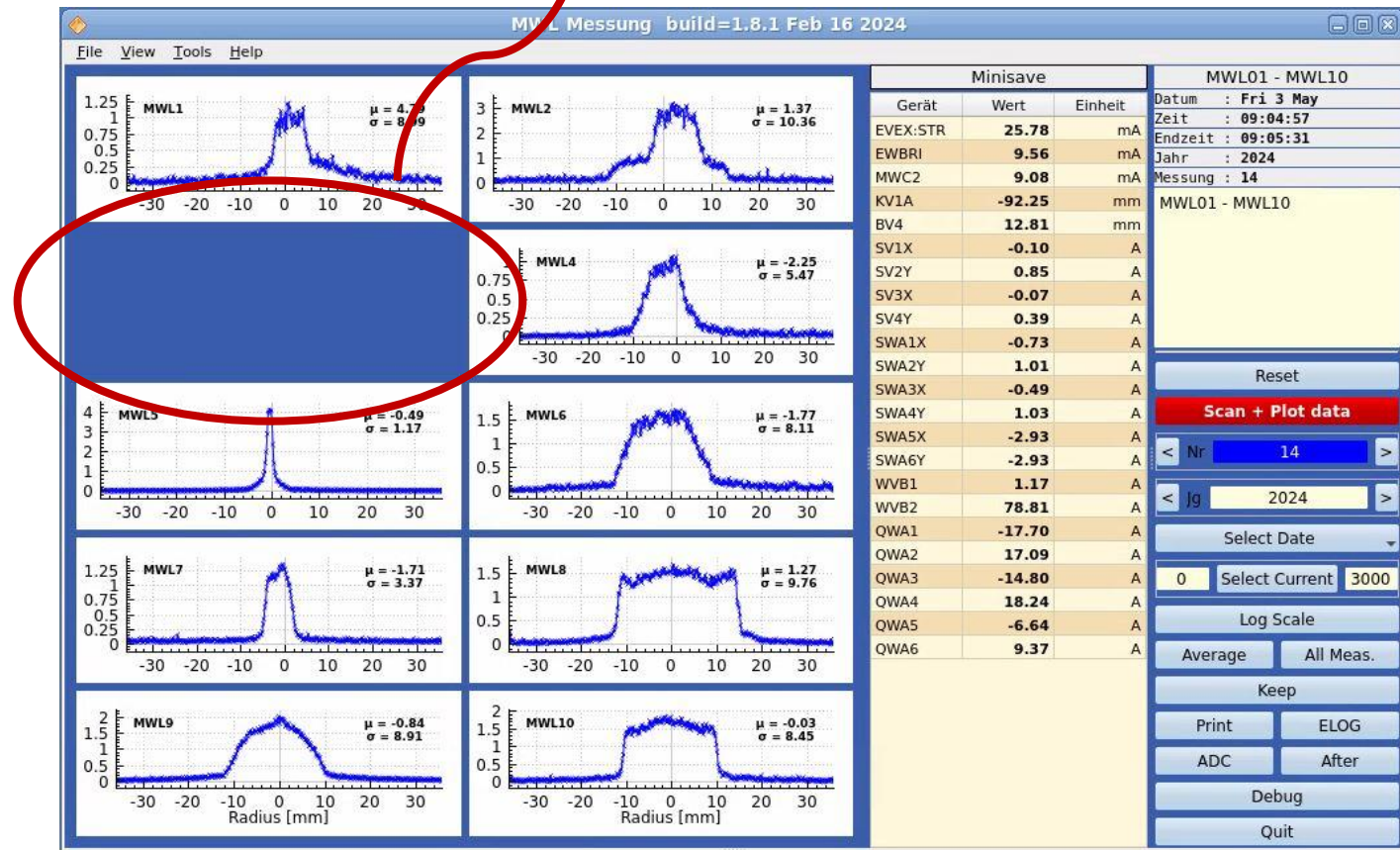
Context and Motivation

- Obsolete CAMAC electronics
So replacement is necessary in any case
- Currently there are not a lot BIF monitors in operation

New monitors will be built. Stay with old technology?

- Use opportunity and suggest a simple solution

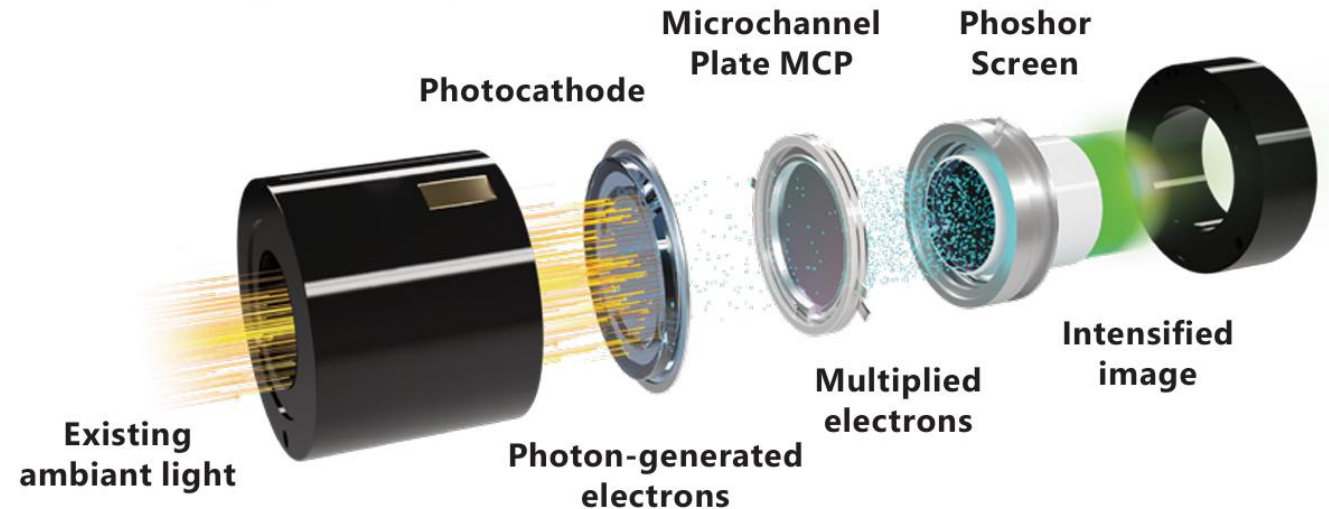
My Measurement



Choice of Technology – Image Intensifier

- By Exosens (used to be called photonics)
 - 1) Incoming photon is converted into a photoelectron
 - 2) Electron accelerates through internal electrical field towards the micro-channel plate (MCP)
 - 3) There it multiplies several thousand times by impinging on the inner walls (like an avalanche)
 - 4) Phosphor screen converts the electrons back into an optical image

Working Principle



Single MCP illustration

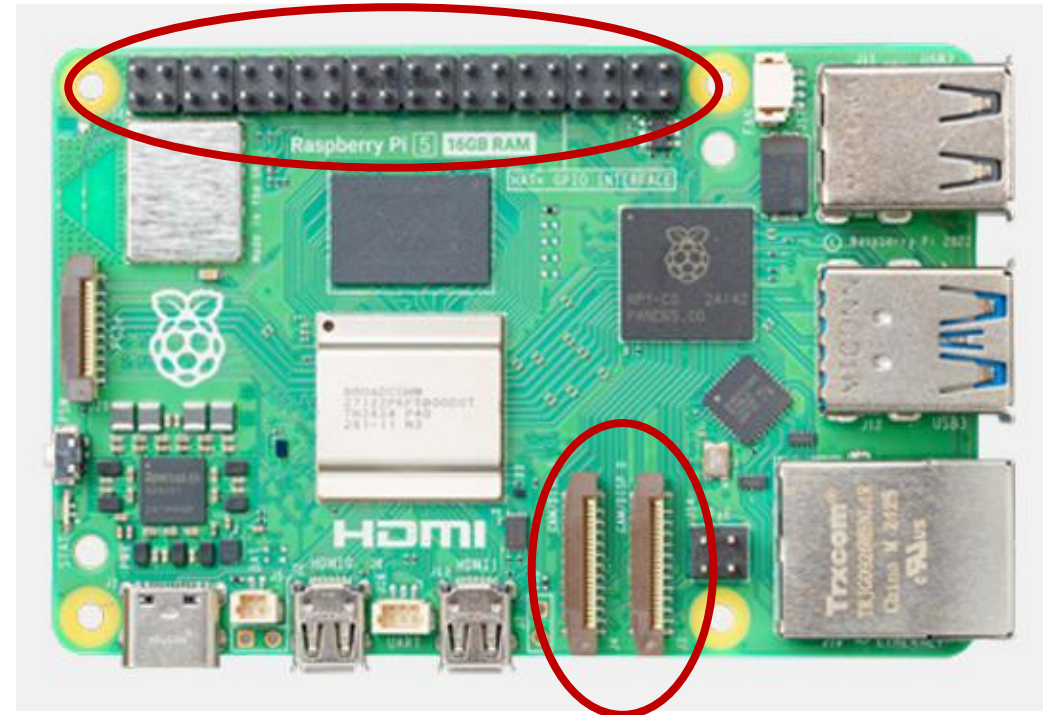
[4]

- Maximum gain: 2 Million times
- Gain control by adjusting internal electrical field through external voltage (0V – 5V)
- Same technology was used in GSI (Darmstadt) and proved itself helpful

Choice of Technology – Raspberry Pi

- ♦ Core of the installation as it enables control of
 - 1) Camera for data acquisition
 - 2) Gain adjustment for the image intensifier
 - 3) Through remote access via the wifi

General Purpose Input/Output (GPIO) Pins

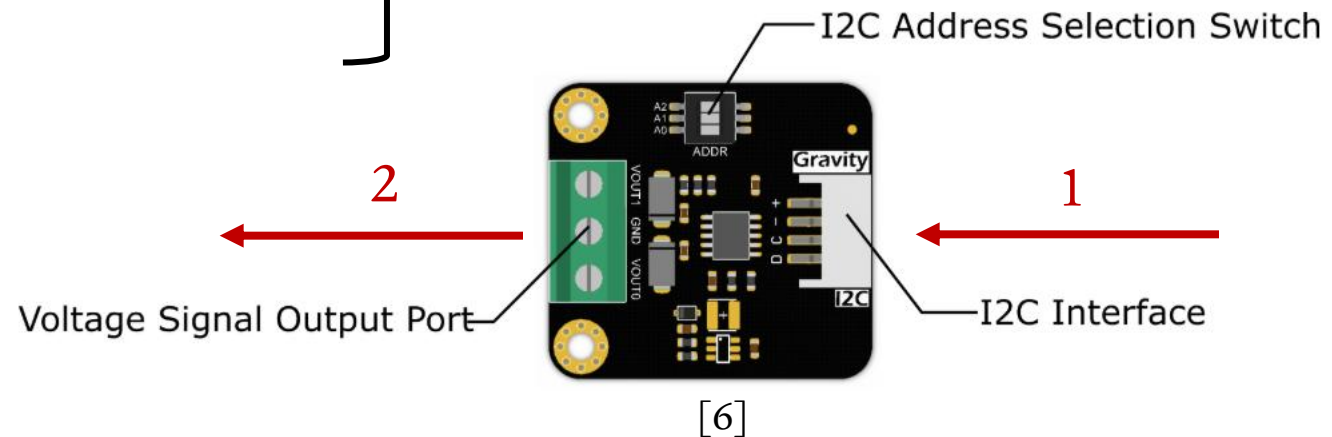


[5]

Camera Serial Interface (CSI) connector

Choice of Technology – DAC Unit

- ◆ Issue: GPIO Pin output is either
 - ◆ LOW = 0V
 - ◆ High = 3.3V
- ◆ Requirement: Continuous control voltage
 - ◆ 0-5V analog signal



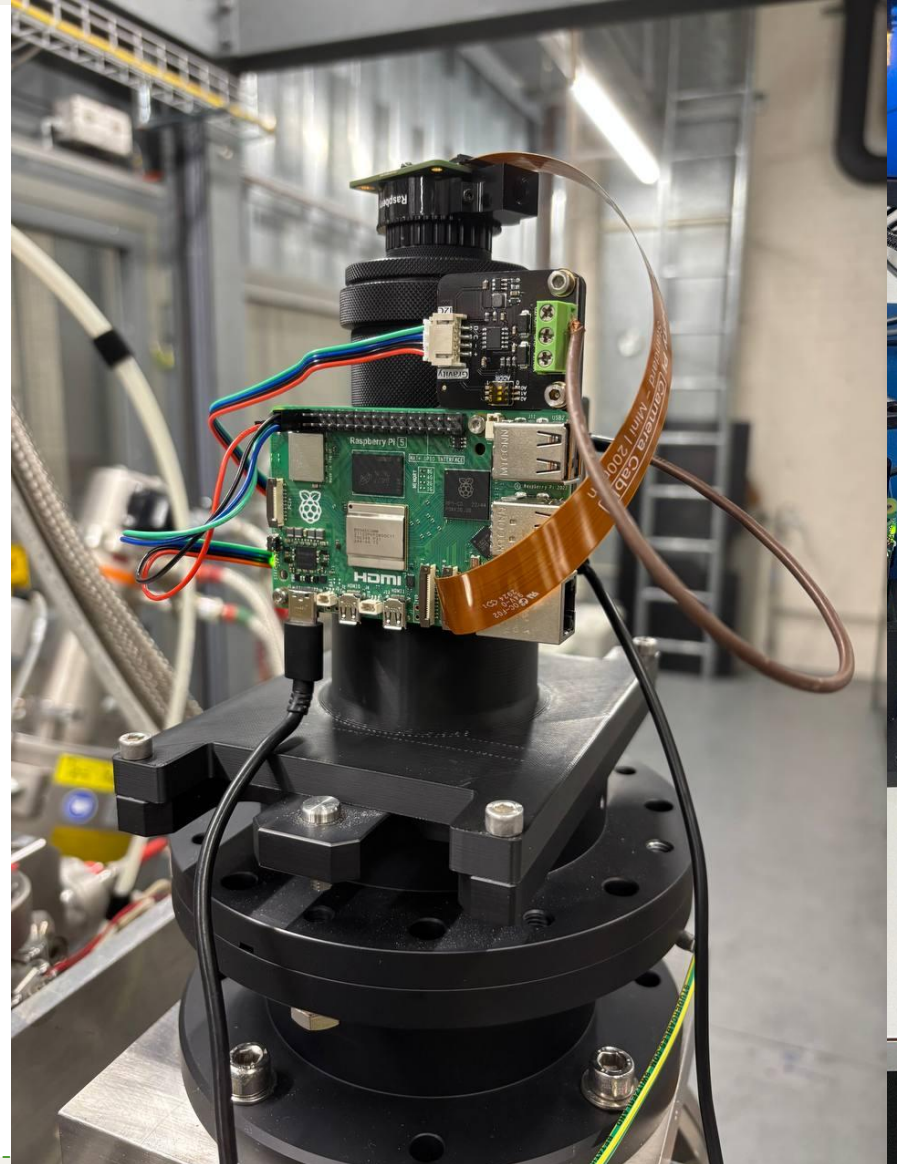
Choice of Technology – Camera and lens

- ♦ Camera by raspberry pi
- ♦ Several lenses available with different focal distances and aperture settings
 - ♦ Distance to beam
 - ♦ Close aperture to increase focus in depth. But decrease amount of light entering the lens
 - ♦ Aperture of the vacuum tube suggests a narrow field of view (next slide)
 - ♦ Pixel to milimeter conversion

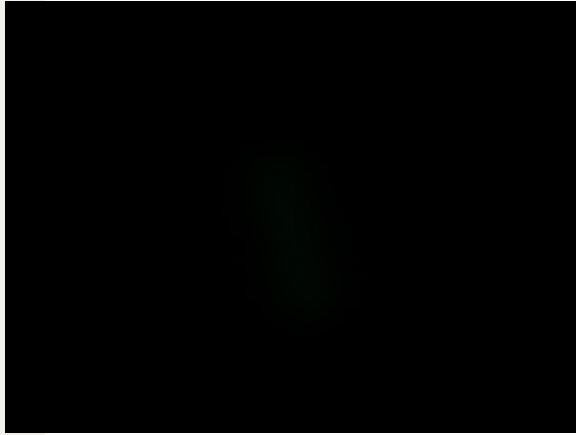


Mounting

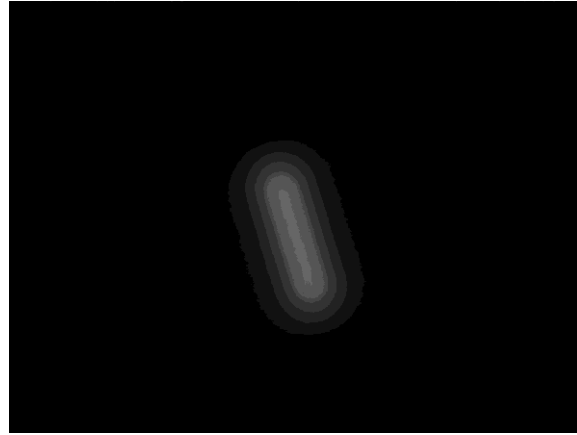
- ◆ Thanks to
 - ◆ Martin
 - ◆ Simon



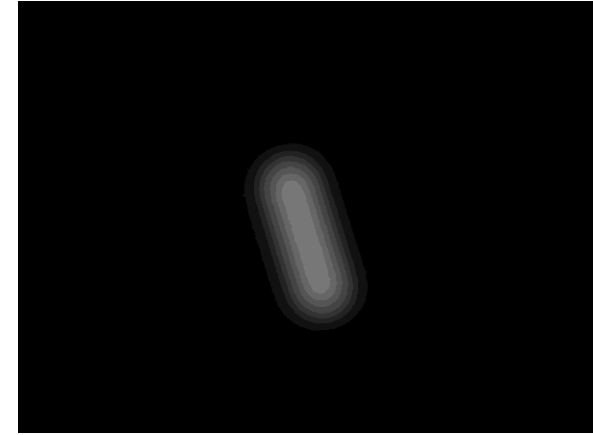
Results



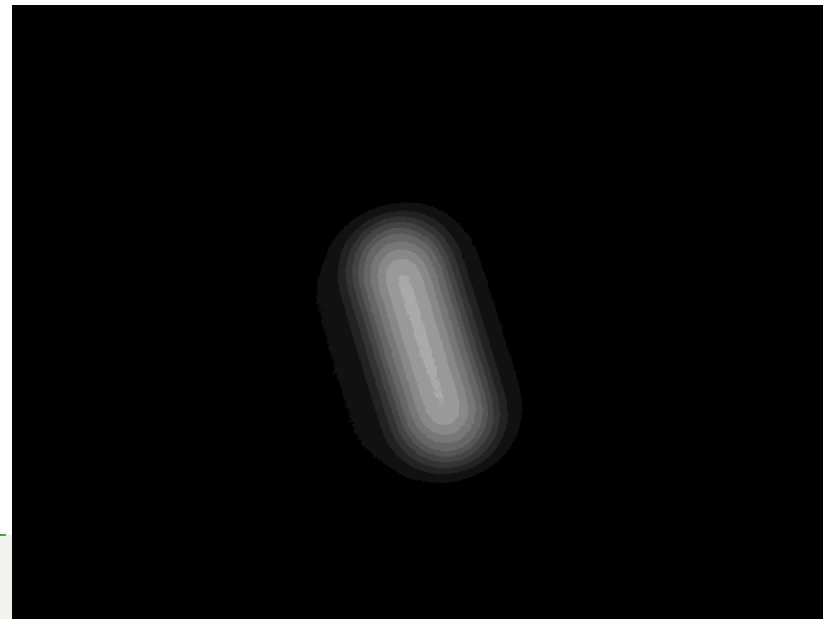
Gain: 0.0V



Gain: 0.0V
Overlay: 20 pictures

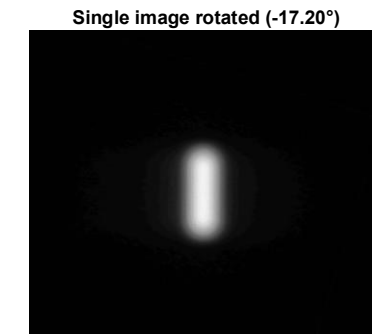
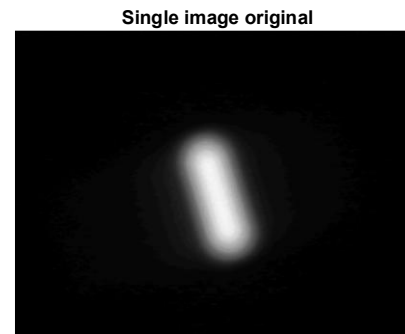
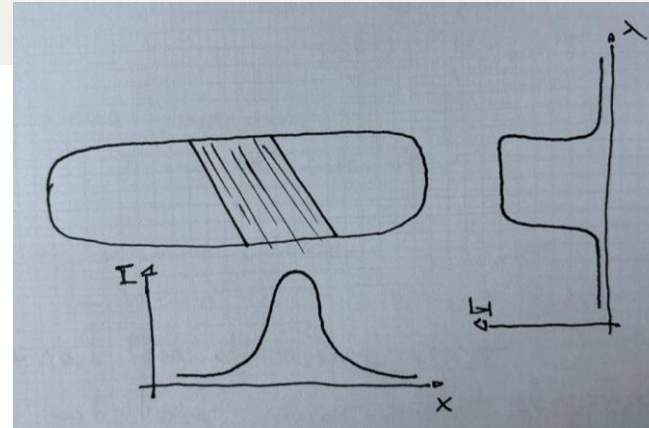
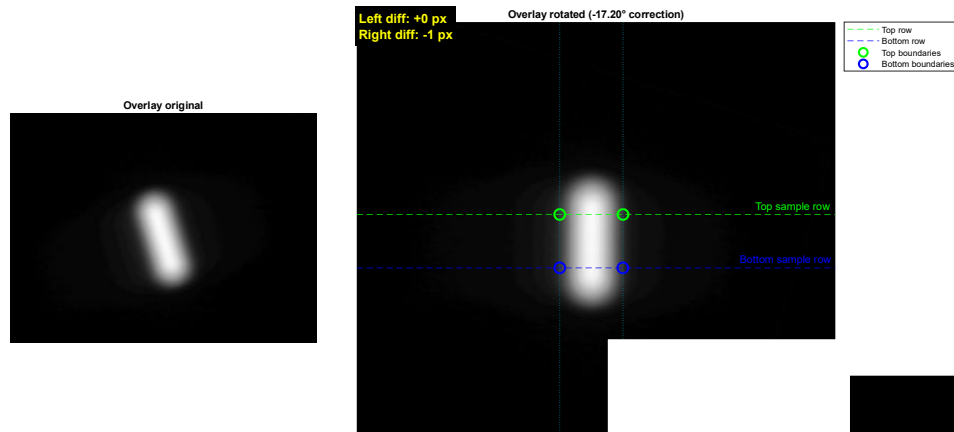


Gain: 0.0V
Overlay: 5 pictures
Shutter time: 500 ms

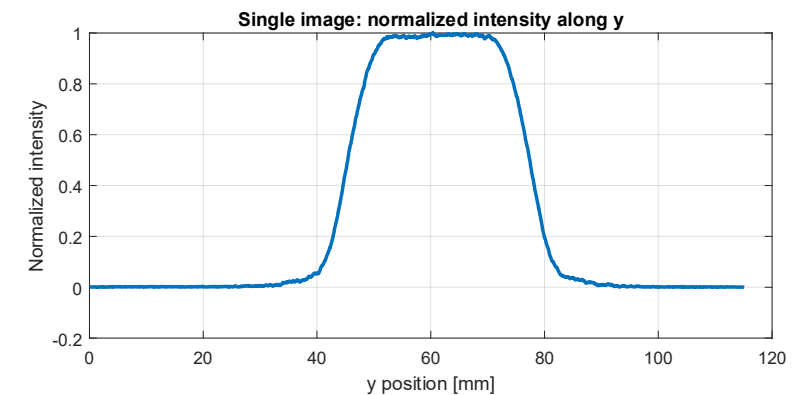
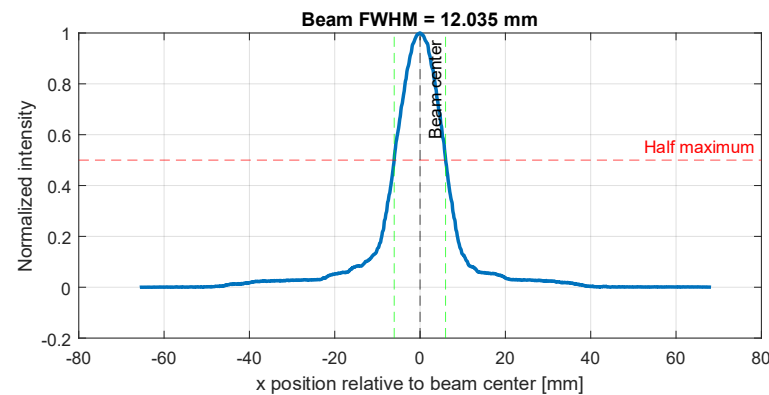


Gain: 0.0V
Overlay: 4 pictures
Shutter time: 1000 ms

Results



1. Identifies object and its main axis
2. Calculates the rotation w.r.t. the horizontal axis (negative means clockwise)
3. Applies 90° - rotation correction
4. Checks how many pixel difference the top and bottom sample row have for validation



Perspective

- ♦ Radiation shielding
 - ♦ New mount including a box covering the electronics
- ♦ Upgrading the mounting from PLA to tungsten incorporated materials for robustness
- ♦ Replacing the very simple raspberry pi with a more suitable solution
- ♦ Sources of Error:
 - ♦ Lens Calibration
 - ♦ Picture settings (e.g. shutter time)
 - ♦ Code (rotation & result extraction)
 - ♦ DAC Unit output has an error of plus minus 0.02%
- ♦ Improvements:
 - ♦ Simplify user interface
E.g. changing gain and overlaying pictures...replace with one single alias

References

- ♦ [1]: SG Arutunian, AV Margaryan, GS Harutyunyan, EG Lazareva, Moses Chung, D Kwak, and DS Gyulamiryan. Vibrating wire monitor: Versatile instrumentation for particle and photon beam measurements with wide dynamic range. *Journal of Instrumentation*, 16(01):R01001–R01001, 2021.
- ♦ [2]: P Forck, C Andre, F Becker, R Haseitl, and B Walasek-Höhne. Beam induced fluorescence profile monitor developments. HB2010, Morschach, Switzerland, page 497, 2010.
- ♦ [3]: F Becker et al. Beam induced fluorescence monitors. WEOD01, Proceedings of DIPAC, 2011. doi: 10.18429/JACoW-DIPAC2011-WEOD01.
- ♦ [4]: Exosens. Image intensifiers for scientific applications, 2024. URL <https://www.exosens.com/products/detection-analytical-science/image-intensifiers-scientific-applications>.

References

- ♦ [5]: Raspberry, 2012. URL <https://www.raspberrypi.com/>
- ♦ [6]: DFRobot. URL <https://www.dfrobot.com/product-2756.html>